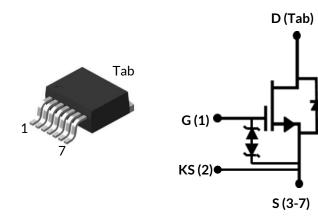


### $1200V\text{-}410m\Omega\,\text{SiC}\,\text{FET}$

Rev. B, December 2022

#### DATASHEET

# UF3C120400B7S



Part Number	Package	Marking
UF3C120400B7S	D <sup>2</sup> PAK-7L	UF3C120400B7S



#### Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the D<sup>2</sup>PAK-7L package, this device exhibits ultralow gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads , and any application requiring standard gate drive.

#### Features

- On-resistance R<sub>DS(on)</sub>: 410mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q<sub>rr</sub> = 51nC
- Low body diode V<sub>FSD</sub>: 1.5V
- Low gate charge: Q<sub>G</sub> = 22.5nC
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3

#### **Typical applications**

- Switching power supplies
- Auxiliary power supplies
- Load switches





#### Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V <sub>DS</sub>		1200	V
Gate-source voltage	V <sub>GS</sub>	DC	-25 to +25	V
Continuous drain current <sup>1</sup>	1	T <sub>C</sub> = 25°C	7.6	А
	ID	T <sub>C</sub> = 100°C	5.9	А
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	14	А
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =1.25A	11.7	mJ
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	100	W
Maximum junction temperature	T <sub>J,max</sub>		175	°C
Operating and storage temperature	T <sub>J</sub> , T <sub>STG</sub>		-55 to 175	°C
Reflow soldering temperature	T <sub>solder</sub>	reflow MSL 1	245	°C

1. Limited by  $T_{J,max}$ 

2. Pulse width  $t_{p}$  limited by  $T_{J,\text{max}}$ 

3. Starting  $T_J = 25^{\circ}C$ 

#### **Thermal Characteristics**

Parameter	Symbol	Test Conditions	Value			- Units
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			1.2	1.5	°C/W



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#### Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

#### **Typical Performance - Static**

Parameter	Symbol	Test Conditions	Value			Linte
			Min	Тур	Max	- Units
Drain-source breakdown voltage	BV <sub>DS</sub>	$V_{GS}$ =0V, $I_{D}$ =1mA	1200			V
Total drain leakage current		V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		0.4 60		
	I <sub>DSS</sub>	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =175°C		4		μA
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		6	±20	μA
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =5A, T <sub>J</sub> =25°C		410	515	
		V <sub>GS</sub> =12V, I <sub>D</sub> =5A, T <sub>J</sub> =125°C		780		mΩ
		V <sub>GS</sub> =12V, I <sub>D</sub> =5A, T <sub>J</sub> =175°C		1070		
Gate threshold voltage	V <sub>G(th)</sub>	$V_{DS}$ =5V, $I_{D}$ =10mA	3	4.7	6	V
Gate resistance	R <sub>G</sub>	f=1MHz, open drain		4.1		Ω

#### Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		- Units			
			Min	Тур	Max	Units	
Diode continuous forward current <sup>1</sup>	I <sub>S</sub>	T <sub>C</sub> =25°C			7.6	Α	
Diode pulse current <sup>2</sup>	I <sub>S,pulse</sub>	T <sub>C</sub> =25°C			14	А	
Forward voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =2A, T <sub>J</sub> =25°C		1.5	1.75	V	
		V <sub>GS</sub> =0V, I <sub>S</sub> =2A, T <sub>J</sub> =175°C		2.4		v	
Reverse recovery charge	Q <sub>rr</sub>	V <sub>DS</sub> =800V, I <sub>S</sub> =5A, V <sub>GS</sub> =-5V, R <sub>G_EXT</sub> =10Ω		51		nC	
Reverse recovery time	t <sub>rr</sub>	di/dt=4000A/μs, Τ <sub>J</sub> =25°C		24		ns	
Reverse recovery charge	Q <sub>rr</sub>	$V_{DS}$ =800V, I <sub>S</sub> =5A, $V_{GS}$ =-5V, R <sub>G_EXT</sub> =10 $\Omega$		52		nC	
Reverse recovery time	t <sub>rr</sub>	di/dt=4000A/μs, Τ <sub>J</sub> =150°C		24		ns	





#### Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Linite
			Min	Тур	Max	Units
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V		739		
Output capacitance	C <sub>oss</sub>	f=100kHz		14.8		pF
Reverse transfer capacitance	C <sub>rss</sub>	1-100KHZ		2		
Effective output capacitance, energy related	C <sub>oss(er)</sub>	$V_{DS}=0V$ to 800V, $V_{GS}=0V$		17.5		pF
Effective output capacitance, time related	C <sub>oss(tr)</sub>	$V_{DS}$ =0V to 800V, $V_{GS}$ =0V		36		pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V		5.6		μJ
Total gate charge	Q <sub>G</sub>	- V <sub>DS</sub> =800V, I <sub>D</sub> =5A, -		22.5		nC
Gate-drain charge	$Q_{GD}$	$V_{\rm DS} = 0000, N_{\rm D} = 5000, V_{\rm CS} = 00000000000000000000000000000000000$		6		
Gate-source charge	Q <sub>GS</sub>	VGS - 0V 1013V		5.5		
Turn-on delay time	t <sub>d(on)</sub>			34		- ns
Rise time	t <sub>r</sub>	$V_{DS}$ =800V, $I_D$ =5A, Gate		10		
Turn-off delay time	t <sub>d(off)</sub>	Driver =0V to +15V, Turn-on $R_{G,EXT}$ =33 $\Omega$ , Turn-off $R_{G,EXT}$ =8 $\Omega$ Inductive Load, FWD: UJ3D1202TS, T_=25°C		33		
Fall time	t <sub>f</sub>			25		
Turn-on energy	E <sub>ON</sub>			70		
Turn-off energy	E <sub>OFF</sub>			20		μJ
Total switching energy	E <sub>TOTAL</sub>			90		
Turn-on delay time	t <sub>d(on)</sub>			28		- ns
Rise time	t <sub>r</sub>	$V_{DS}$ =800V, $I_D$ =5A, Gate Driver =0V to +15V, Turn-on $R_{G,EXT}$ =33 $\Omega$ , Turn-off $R_{G,EXT}$ =8 $\Omega$ Inductive Load, FWD: UJ3D1202TS, $T_J$ =150°C		8.8		
Turn-off delay time	t <sub>d(off)</sub>			34		
Fall time	t <sub>f</sub>			25		1
Turn-on energy	E <sub>ON</sub>			64		
Turn-off energy	E <sub>OFF</sub>			18		μJ
Total switching energy	E <sub>total</sub>			82		

## Typical Performance Diagrams

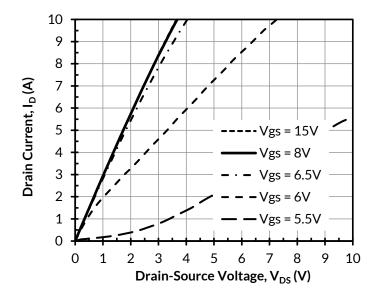
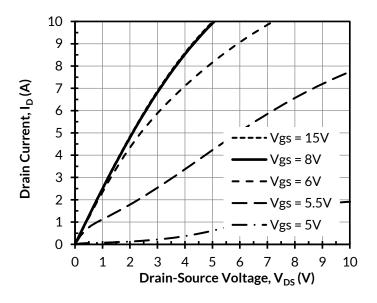


Figure 1. Typical output characteristics at T  $_{\rm J}$  = - 55°C, tp < 250 $\mu s$ 



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Figure 2. Typical output characteristics at  $T_J$  = 25°C, tp < 250 $\mu$ s

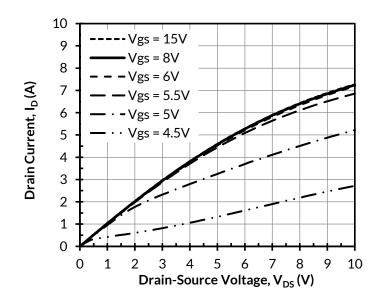


Figure 3. Typical output characteristics at T  $_{\rm J}$  = 175°C, tp < 250 $\mu s$ 

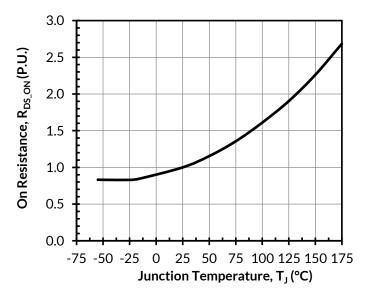


Figure 4. Normalized on-resistance vs. temperature at  $V_{GS}$  = 12V and  $I_D$  = 5A

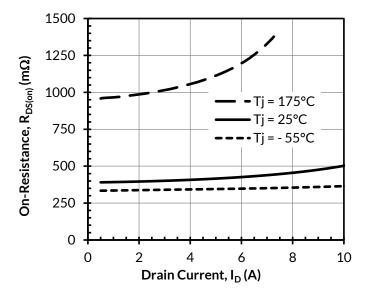
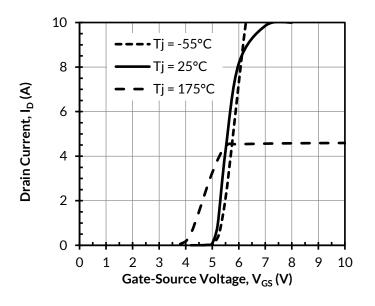


Figure 5. Typical drain-source on-resistances at  $V_{GS}$  = 12V



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Figure 6. Typical transfer characteristics at  $V_{DS}$  = 5V

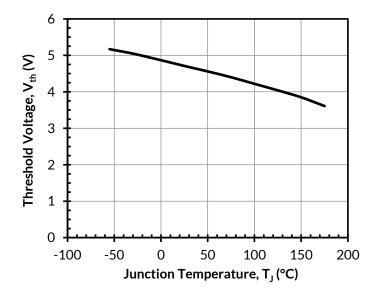


Figure 7. Threshold voltage vs. junction temperature at  $V_{\text{DS}}$  = 5V and  $I_{\text{D}}$  = 10mA

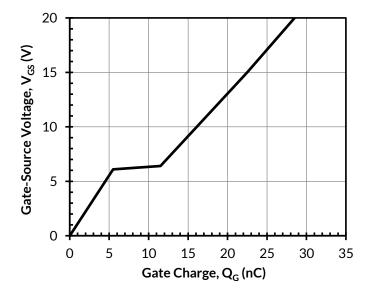


Figure 8. Typical gate charge at  $V_{\text{DS}}$  = 800V and  $I_{\text{D}}$  = 5A

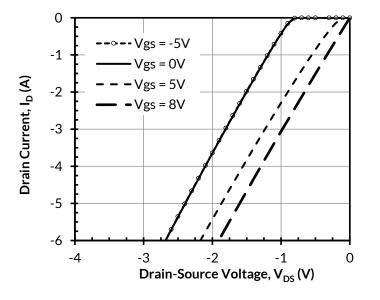


Figure 9. 3rd quadrant characteristics at  $T_J = -55^{\circ}C$ 

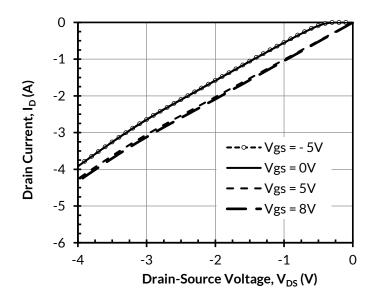
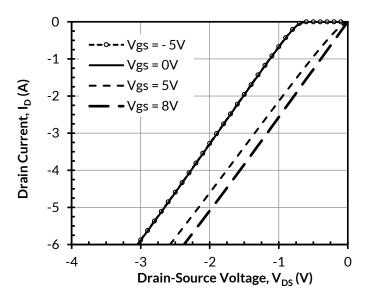


Figure 11. 3rd quadrant characteristics at T<sub>J</sub> = 175°C



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Figure 10. 3rd quadrant characteristics at  $T_J = 25^{\circ}C$ 

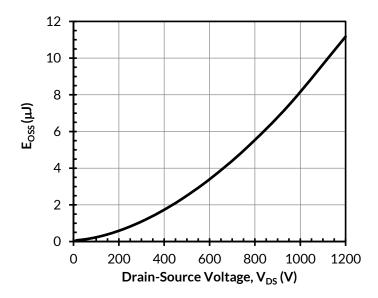


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS}$  = 0V

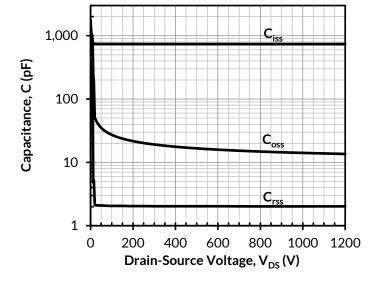
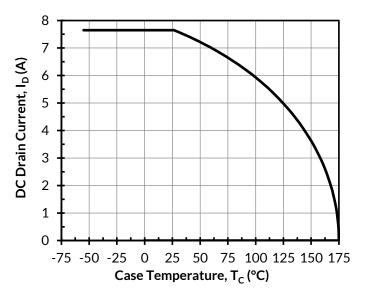


Figure 13. Typical capacitances at f = 100kHz and  $V_{\rm GS}$  = 0V



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Figure 14. DC drain current derating

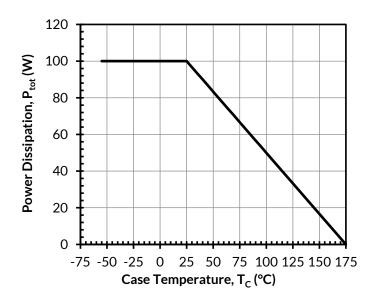


Figure 15. Total power dissipation

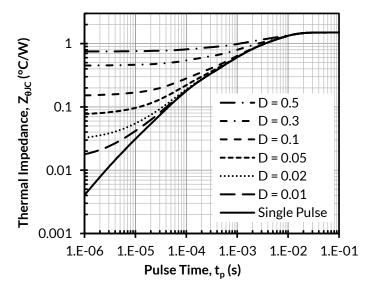


Figure 16. Maximum transient thermal impedance

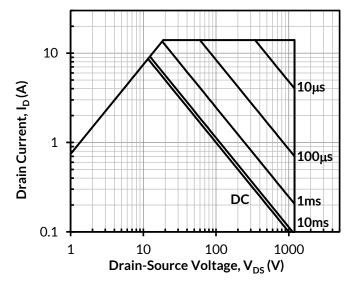
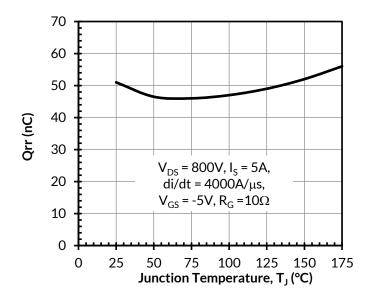


Figure 17. Safe operation area at  $T_{C}$  = 25°C, D = 0, Parameter  $t_{\rm p}$ 



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Figure 18. Reverse recovery charge Qrr vs. junction temperature

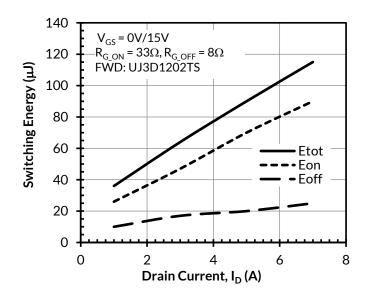


Figure 19. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 800V and  $T_J$  = 25°C

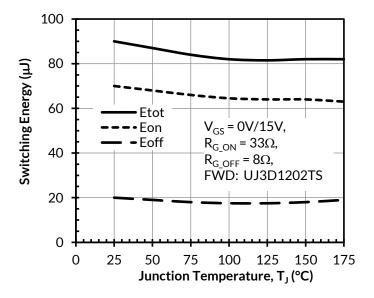


Figure 20. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 800V and  $I_D$  = 5A

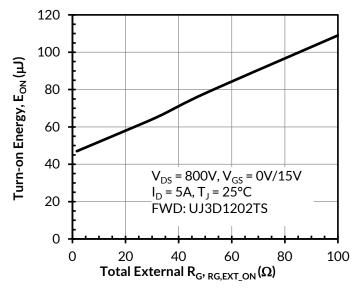
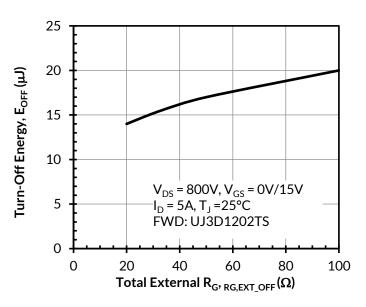


Figure 20. Clamped inductive switching turn-on energy vs.  $R_{G,\text{EXT\_ON}}$ 



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Figure 21. Clamped inductive switching turn-off energy vs.  $R_{G,EXT_OFF}$ 

#### **Applications Information**

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

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Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small  $R_{(G)}$ , or gate resistor, provides better EMI suppression with higher efficiency compared to using a high  $R_{(G)}$  value. There is no extra gate delay time when using the snubber circuitry, and a small  $R_{(G)}$  will better control both the turn-off  $V_{(DS)}$  peak spike and ringing duration, while a high  $R_{(G)}$  will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high  $R_{(G)}$ , while greatly reducing  $E_{(OFF)}$  from mid-to-full load range with only a small increase in  $E_{(ON)}$ . Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com





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